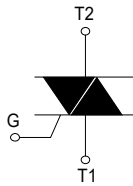
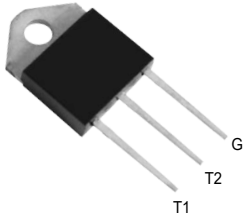
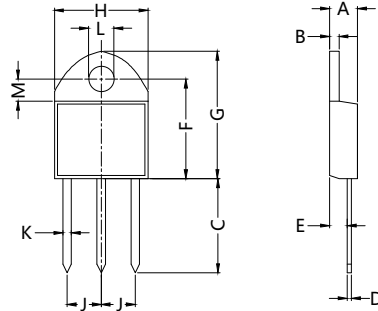


# BTA26

## Discrete Triacs(Isolated)



Dimensions TO-218



Dim.	Millimeter	
	Min.	Max.
A	4.40	4.70
B	1.45	1.65
C	14.50	16.10
D	0.45	0.80
E	2.60	2.95
F	15.80	17.00
G	20.10	21.20
H	15.00	15.80
J	5.30	5.75
K	1.25	1.55
∅L	4.00	4.25
M	3.45	3.75

Type	V <sub>RSM</sub>	V <sub>RRM</sub>
	V <sub>DSTM</sub>	V <sub>DRM</sub>
	V	V
BTA26-400	500	400
BTA26-600	700	600
BTA26-800	900	800
BTA26-1000	1100	1000
BTA26-1200	1300	1200



### ABSOLUTE MAXIMUM RATINGS

UL 310749

Symbol	Parameter	Value	Unit
I <sub>T(RMS)</sub>	RMS on-state current (full sine wave)	TO-218 T <sub>c</sub> = 100°C	25 A
I <sub>TSM</sub>	Non repetitive surge peak on-state current (full cycle, T <sub>j</sub> initial = 25°C)	F=60Hz t=16.7ms	250 A
		F=50Hz t=20ms	260
I <sup>2</sup> <sub>t</sub>	I <sup>2</sup> <sub>t</sub> Value for fusing	tp=10 ms	340 A <sup>2</sup> s
di/dt	Critical rate of rise of on-state current I <sub>G</sub> = 2 x I <sub>GT</sub> , tr ≤ 100 ns	F=120 Hz T <sub>j</sub> =125°C	50 A/μs
V <sub>DSTM</sub> /V <sub>RSM</sub>	Non repetitive surge peak off-state voltage	tp=10ms T <sub>j</sub> =25°C	V <sub>DRM</sub> /V <sub>RRM</sub> + 100 V
I <sub>GM</sub>	Peak gate current	tp=20μs T <sub>j</sub> =125°C	4 A
P <sub>G(AV)</sub>	Average gate power dissipation	T <sub>j</sub> =125°C	1 W
T <sub>stg</sub> T <sub>j</sub>	Storage junction temperature range Operating junction temperature range		- 40 to + 150 - 40 to + 125 °C

### ELECTRICAL CHARACTERISTICS (T<sub>j</sub> = 25°C, unless otherwise specified)

#### ■ SNUBBERLESS and LOGIC LEVEL(3 Quadrants)

Symbol	Test Conditions	Quadrant	BTA26		Unit	
			CW	BW		
I <sub>GT</sub>	V <sub>D</sub> =12 V R <sub>L</sub> =33 Ω	I - II - III	MAX.	35	50	mA
V <sub>GT</sub>		I - II - III	MAX.	1.3		V
V <sub>GD</sub>	V <sub>D</sub> =V <sub>DRM</sub> R <sub>L</sub> =3.3 kΩ T <sub>j</sub> =125°C	I - II - III	MIN.	0.2		V
I <sub>H</sub>	I <sub>T</sub> = 500mA		MAX.	50	75	mA
I <sub>L</sub>	I <sub>G</sub> =1.2I <sub>GT</sub>	I - III	MAX.	70	80	mA
		II		80	100	
dV/dt	V <sub>D</sub> = 67 % V <sub>DRM</sub> gate open T <sub>j</sub> =125°C		MIN.	500	1000	V/μs
(di/dt) <sub>c</sub>	Without snubber T <sub>j</sub> =125°C		MIN.	13	22	A/ms

V<sub>ISO</sub>>2500VAC 1min



# BTA26

## Discrete Triacs(Isolated)

### ■ STANDARD (4 Quadrants)

Symbol	Test Conditions	Quadrant		Value	Unit
$I_{GT}$	$V_D=12\text{ V}$ $R_L=33\ \Omega$	I - II - III IV	MAX.	50 100	mA
$V_{GT}$		ALL	MAX.	1.3	V
$V_{GD}$	$V_D=V_{DRM}$ $R_L=3.3\ \Omega$ $T_j=125^\circ\text{C}$	ALL	MIN.	0.2	V
$I_H$	$I_T=500\text{mA}$		MAX.	80	mA
$I_L$	$I_G=1.2 I_{GT}$	I - III - IV	MAX.	70	mA
		II		160	
dV/dt	$V_D=67\% V_{DRM}$ gate open $T_j=125^\circ\text{C}$		MIN.	500	V/ $\mu\text{s}$
(dV/dt)c	(dI/dt)c=13.3 A/ms $T_j=125^\circ\text{C}$		MIN.	10	V/ $\mu\text{s}$

### STATIC CHARACTERISTICS

Symbol	Test Conditions			Value	Unit
$V_{TM}$	$I_{TM}=25\text{A}$ $t_p=380\mu\text{s}$	$T_j=25^\circ\text{C}$	MAX.	1.55	V
$V_{to}$	Threshold voltage	$T_j=125^\circ\text{C}$	MAX.	0.85	V
$R_d$	Dynamic resistance	$T_j=125^\circ\text{C}$	MAX.	16	m $\Omega$
$I_{DRM}$	$V_{DRM}=V_{RRM}$	$T_j=25^\circ\text{C}$	MAX.	5	$\mu\text{A}$
$I_{RRM}$		$T_j=125^\circ\text{C}$		3	mA

### THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th(j-c)}$	Junction to case (AC)	0.8	$^\circ\text{C/W}$
$R_{th(j-a)}$	Junction to ambient	60	$^\circ\text{C/W}$

### PRODUCT SELECTOR

Part Number	Voltage (xxx)		Sensitivity	Type	Package
	200 V	~ ~ 1800 V			
BTA26	X	X	50 mA	Standard	TO-218

### OTHER INFORMATION

Part Number	Marking	Weight	Base quantity	Packing mode
BTA26	BTA26	4.6g	30	Tube

**Sirectifier**<sup>®</sup>

# BTA26

## Discrete Triacs(Isolated)

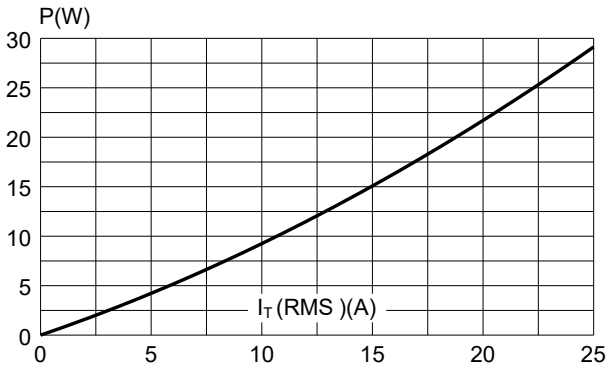


Fig.1:Maximum power dissipation versus RMS on-state current (full cycle).

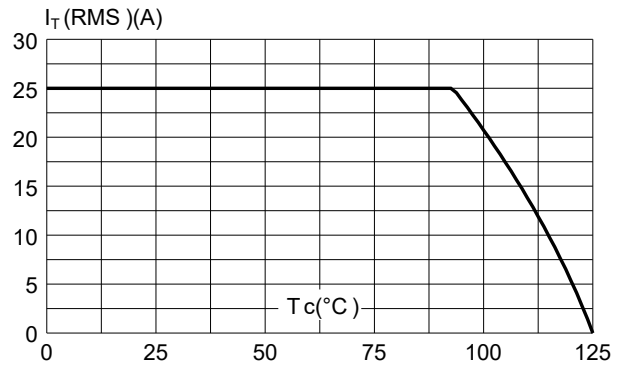


Fig.2:RMS on-state current versus case temperature (full cycle).

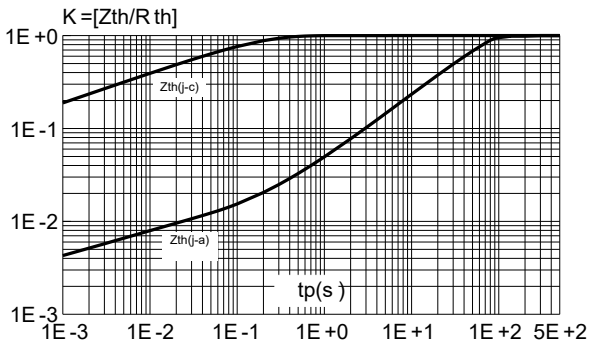


Fig.3:Relative variation of thermal impedance versus pulse duration.

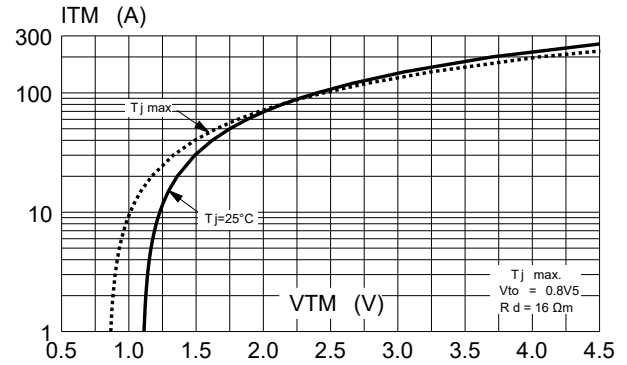


Fig.4:On-state characteristics (maximum values ).

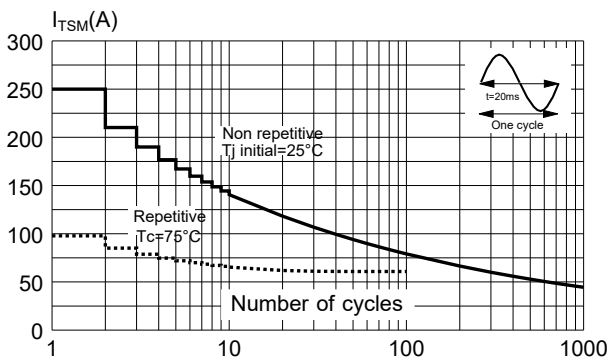


Fig.5:Surgepeak on-state current versus number of cycles.

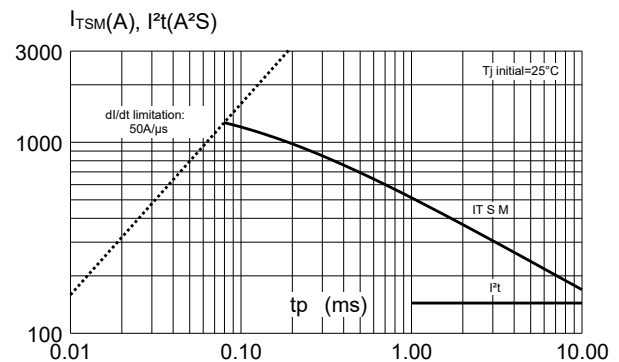


Fig.6:Non-repetitive surge peak on-state current

for a sinusoidal pulse with width  $tp < 10ms$ , and corresponding value of  $I^2t$ .

# BTA26

## Discrete Triacs(Isolated)

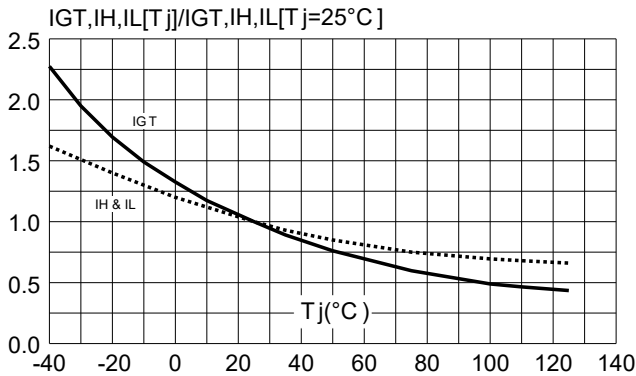


Fig.7:Relative variation of gate trigger current, holding current and latching current versus junction temperature (typical values ).

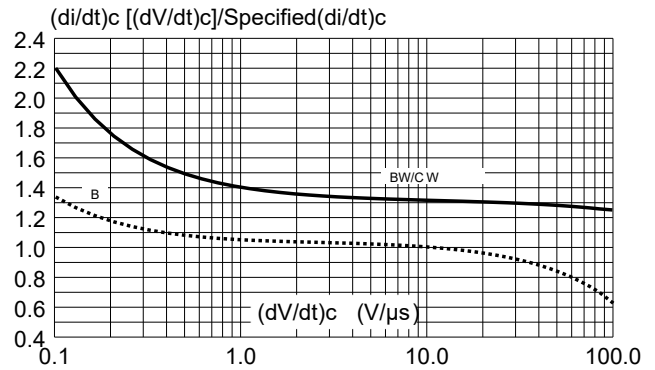


Fig.8:Relative variation of critical rate of decrease of main current versus  $(dV/dt)_c$  (typical values ).

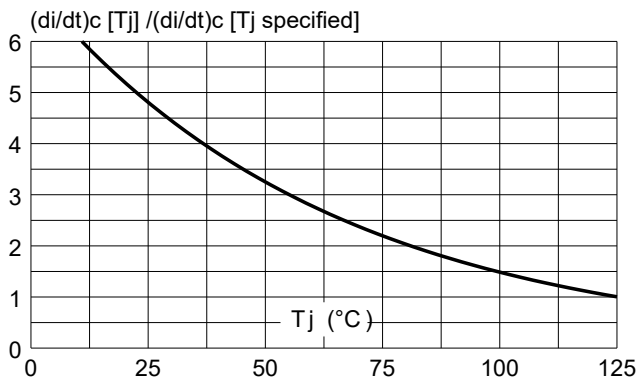


Fig.9:Relative variation of critical rate of decrease of main current versus junction temperature.